



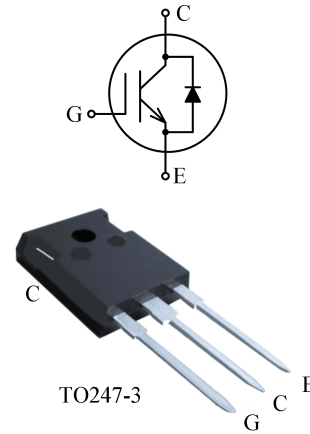
本产品符合 AEC-Q101 标准要求

IGBT in advanced FS Technology with soft and fast recovery anti-parallel diode
具有先进 FS 技术的 IGBT 且反并联软快恢复二极管

Features:

特性

- 1200V planar field-stop technology
1200V 平面栅场终止技术
- Low switching losses
低开关损耗
- Positive temperature coefficient
饱和电压正温度系数
- Positive temperature coefficient of forward voltage
正向电压正温度系数
- Short Circuit withstand time-10 μ s
具备10 μ s短路承受能力



Applications:

应用

- Electric Automotive Air-Condition Compressor
电动汽车空调压缩机
- Electric Automotive PTC Heater
汽车PTC加热
- General Inverter
通用变频器

Type 型号	V_{CE} [V] 集电极-发射极电压	I_C [A] 集电极电流	V_{CEsat} [V] 饱和电压	T_{jmax} [°C] 最高结温	Marking 标记	Package 封装
BGN40Q120SD	1200	40	2.2	175	40Q120SD	TO247-3



Maximum Rated Values

最大额定参数

Parameter 参数	Symbol 符号	Value 值	Unit 单位
Collector-emitter voltage, $T_j \geq 25^\circ\text{C}$ 集电极-发射极电压, $T_j \geq 25^\circ\text{C}$	V_{CE}	1200	V
Collector current, $T_C = 25^\circ\text{C}$ 集电极电流, $T_C = 25^\circ\text{C}$	I_C	80	A
Collector current, $T_C = 100^\circ\text{C}$ 集电极电流, $T_C = 100^\circ\text{C}$	I_C	40	
Pulsed collector current, t_p limited by $T_{j\max}$ 集电极脉冲电流, 脉宽时间受 $T_{j\max}$ 限制	$I_{C\text{puls}}$	160	
Diode forward current, $T_C = 25^\circ\text{C}$ 二极管正向电流, $T_C = 25^\circ\text{C}$	I_F	80	
Diode forward current, $T_C = 100^\circ\text{C}$ 二极管正向电流, $T_C = 100^\circ\text{C}$	I_F	40	
Diode pulsed current 二极管脉冲电流	$I_{F\text{puls}}$	160	V
Gate-emitter voltage 栅极-发射极电压	V_{GE}	± 20	
Short Circuit withstand time $V_{GE} = 15\text{V}, V_{CC} \leq 800\text{V}, T_j \leq 150^\circ\text{C}$ 短路耐受时间	t_{sc}	10	
Total power dissipation, $T_C = 25^\circ\text{C}$ 总耗散功率, $T_C = 25^\circ\text{C}$	P_{tot}	428	
Operating junction temperature 最高结温	$T_{j\max}$	175	
Operating junction temperature 工作结温	$T_{j\text{op}}$	$-40 \dots +150$	$^\circ\text{C}$
Storage temperature 储存温度	T_{stg}	$-55 \dots +150$	
Soldering temperature, 1.6mm from case for 10s 焊接温度	T_{st}	260	
Mounting Torque M3 锁装力矩	M_d	0.6	



Thermal Resistance

热阻

Parameter 参数	Symbol 符号	Value 值	Unit 单位
IGBT Thermal resistance junction to case IGBT 结-管壳热阻	$R_{th(j-c)}$	0.35	$^{\circ}\text{C}/\text{W}$
Diode Thermal resistance junction to case 二极管结-管壳热阻	$R_{th(j-c)}$	0.58	$^{\circ}\text{C}/\text{W}$
Thermal resistance junction to ambient 结-环境热阻	$R_{th(j-a)}$	40	$^{\circ}\text{C}/\text{W}$

Electrical Characteristic at $T_j = 25^{\circ}\text{C}$ (unless otherwise specified)

$T_j=25^{\circ}\text{C}$ 时电学特性（除非特别声明）

Parameter 参数	Symbol 符号	Conditions 条件	Value 值			Unit 单位
			Min. 最小值	Typ. 典型值	Max. 最大值	

Static Characteristic

静态特性

Collector-emitter breakdown voltage 集电极-发射极击穿电压	$V_{(BR)CES}$	$V_{GE}=0V$, $I_C=1mA$	1200	-	-	V
Collector-emitter saturation voltage 集电极-发射极饱和电压	V_{cesat}	$V_{GE}=15V$, $I_C=40A$	$T_j=25^{\circ}\text{C}$	-	2.2	2.5
			$T_j=150^{\circ}\text{C}$	-	2.4	-
Diode forward voltage 二极管正向电压	V_F	$V_{GE}=0V$, $I_F=40A$	$T_j=25^{\circ}\text{C}$	-	2.45	2.85
			$T_j=150^{\circ}\text{C}$	-	2.4	-
Gate-emitter threshold voltage 栅极-发射极阈值电压	$V_{GE(th)}$	$I_C=1.6mA$, $V_{CE}=V_{GE}$	5.0	5.8	7.0	μA
Collector-emitter cut-off current 集电极-发射极截止电流	I_{CES}	$V_{CE}=1200V$, $V_{GE}=0V$	-	-	100	
Gate-emitter leakage current 栅极-发射极漏电流	I_{GES}	$V_{CE}=0V$, $V_{GE}=\pm 20V$	-200	-	200	nA

Dynamic Characteristic

动态特性

Input capacitance 输入电容	C_{ies}	$V_{CE}=25V$, $V_{GE}=0V$, $f=1MHz$	-	3825	-	pF
Output capacitance 输出电容	C_{oes}		-	205	-	
Reverse transfer capacitance 反向传输电容	C_{res}		-	110	-	



Gate charge 门极电量	Q_G	$V_{CC}=600V, I_C=40A,$ $V_{GE}=15V$	-	142	-	nC
Internal emitter inductance 内部发射极电感	L_E	-	-	13	-	nH
Short circuit current 短路电流	$I_{C(sc)}$	$V_{CC}=800V, V_{GE}=15V,$ $T_j=150^\circ C$	-	200	-	A
Reverse bias safe operating area 反偏安全工作区	RBSOA	$V_{CC}=800V, V_{GE}=20V,$ $T_j \leq 150^\circ C$	80	-	-	

Switching Characteristic at $T_j=25^\circ C$ (Inductive Load)

$T_j=25^\circ C$ 时开关特性（感性负载）

Parameter 参数	Symbol 符号	Conditions 条件	Value 值			Unit 单位
			Min. 最小值	Typ. 典型值	Max. 最大值	
IGBT Characteristic IGBT 特性						
Turn-on delay time 开通延迟时间	t _{d(on)}	T _j =25℃ , V _{CC} =600V, I _C =40A, V _{GE} =-7.5/15V, R _G =10Ω, Energy losses include “tail” and diode reverse recovery.	-	50	-	ns
Rise time 上升时间	t _r		-	90	-	
Turn-off delay time 关断延迟时间	t _{d(off)}		-	130	-	
Fall time 下降时间	t _f		-	90	-	
Turn-on energy 开通损耗	E _{on}		-	2.9	-	mJ
Turn-off energy 关断损耗	E _{off}		-	1.65	-	
Total switching energy 总开关损耗	E _{ts}		-	4.55	-	

Anti-Parallel Diode Characteristic

反并联二极管特性

Reverse recovery time 反向恢复时间	t_{rr}	$T_j=25^\circ C,$ $V_R=600V,$ $I_F=40A,$ $diF/dt=380A/\mu s$	-	415	-	ns
Recovered charge 恢复电荷	Q_r		-	2.4	-	μC
Peak reverse recovery current 反向恢复峰值电流	I_{RM}		-	13	-	A
Reverse recovered energy 反向恢复损耗	E_{rec}		-	0.9	-	mJ



Switching Characteristic at $T_j=150^{\circ}\text{C}$ (Inductive Load)

$T_j=150^{\circ}\text{C}$ 时开关特性（感性负载）

Parameter 参数	Symbol 符号	Conditions 条件	Value 值			Unit 单位
			Min. 最小值	Typ. 典型值	Max. 最大值	
IGBT Characteristic IGBT 特性						
Turn-on delay time 开通延迟时间	t _{d(on)}	T _J =150℃ , V _{CC} =600V, I _C =40A, V _{GE} =-7.5/15V, R _G =10Ω, Energy losses include “tail” and diode reverse recovery.	-	48	-	ns
Rise time 上升时间	t _r		-	94	-	
Turn-off delay time 关断延迟时间	t _{d(off)}		-	177	-	
Fall time 下降时间	t _f		-	155	-	
Turn-on energy 开通损耗	E _{on}		-	5.7	-	mJ
Turn-off energy 关断损耗	E _{off}		-	2.6	-	
Total switching energy 总开关损耗	E _{ts}		-	8.3	-	

Anti-Parallel Diode Characteristic

反并联二极管特性

Reverse recovery time 反向恢复时间	t_{rr}	$T_j=150^{\circ}\text{C}$, $V_R=600\text{V}$, $I_F=40\text{A}$, $diF/dt=345\text{A}/\mu\text{s}$	-	635	-	ns
Recovered charge 恢复电荷	Q_r		-	5.1	-	μC
Peak reverse recovery current 反向恢复峰值电流	I_{RM}		-	15	-	A
Reverse recovered energy 反向恢复损耗	E_{rec}		-	1.88	-	mJ

ELECTRICAL CHARACTERISTICS

特性曲线

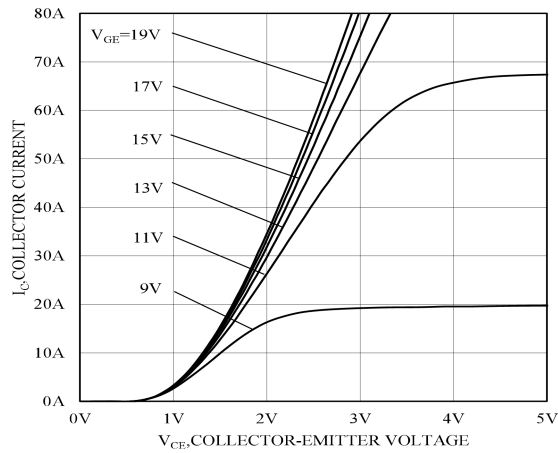


Figure 1. Typical output characteristic($T_j=25^{\circ}\text{C}$)

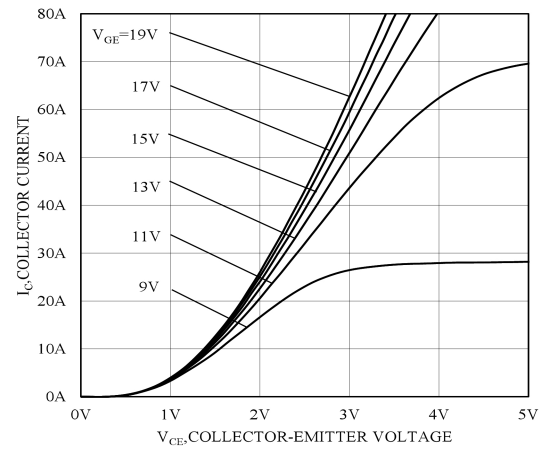


Figure 2. Typical output characteristic($T_j=150^{\circ}\text{C}$)

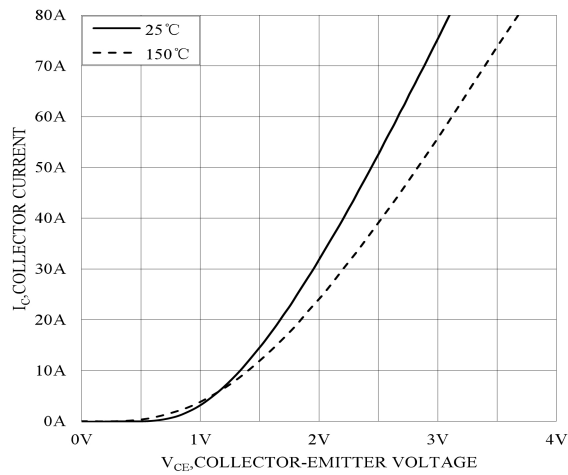


Figure 3. Typical on-state Characteristic($V_{GE}=15\text{V}$)

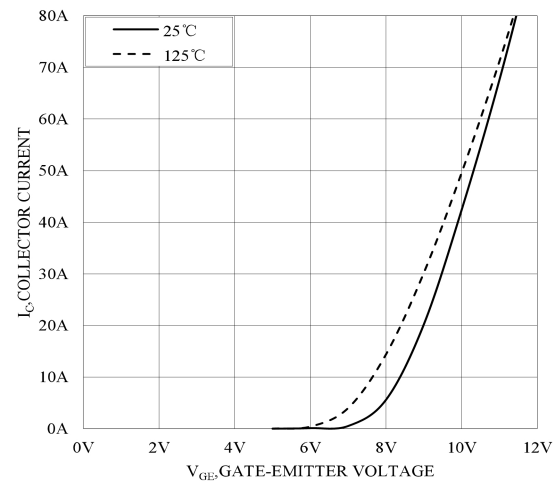


Figure 4. Typical transfer voltage($V_{CE}=20\text{V}$)

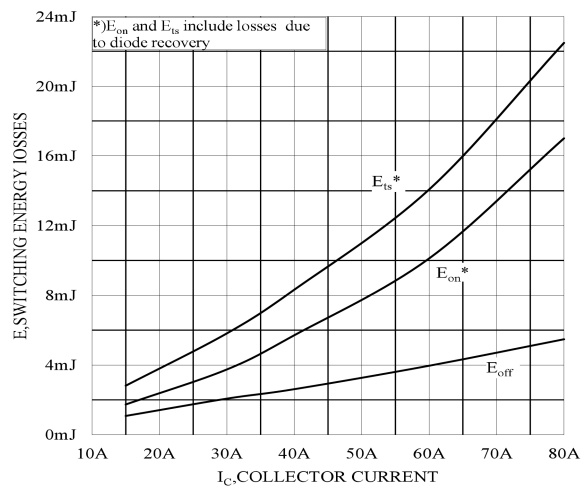


Figure 5. Switching energy losses as I_C
($T_j=150^{\circ}\text{C}$, $V_{CC}=600\text{V}$, $V_{GE}=-7.5/15\text{V}$, $R_G=10\Omega$)

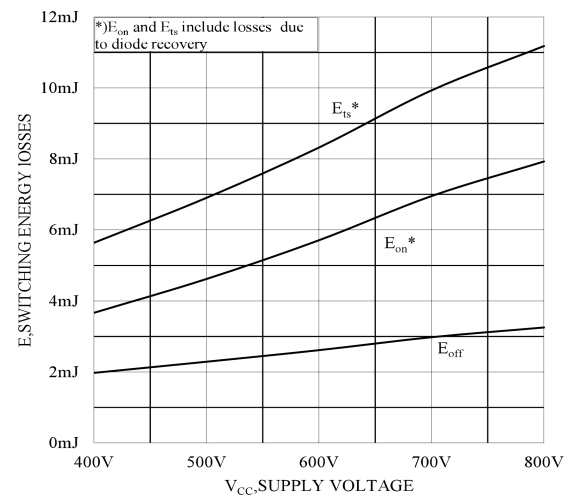


Figure 6. Switching energy losses as V_{CC}
($T_j=150^{\circ}\text{C}$, $V_{GE}=-7.5/15\text{V}$, $I_C=40\text{A}$, $R_G=10\Omega$)

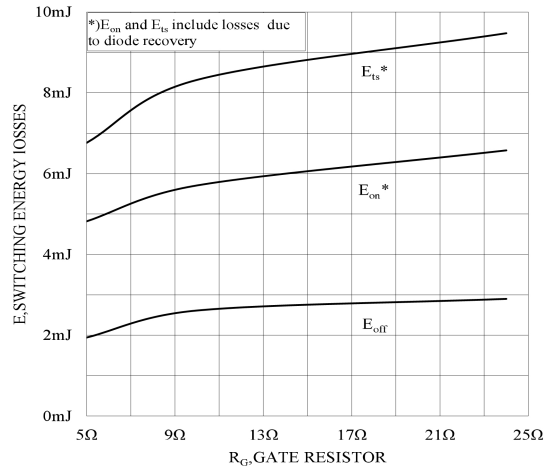


Figure 7. Switching energy losses as R_G
($T_J=150^\circ\text{C}$, $V_{CC}=600\text{V}$, $V_{GE}=-7.5/15\text{V}$, $I_C=40\text{A}$)

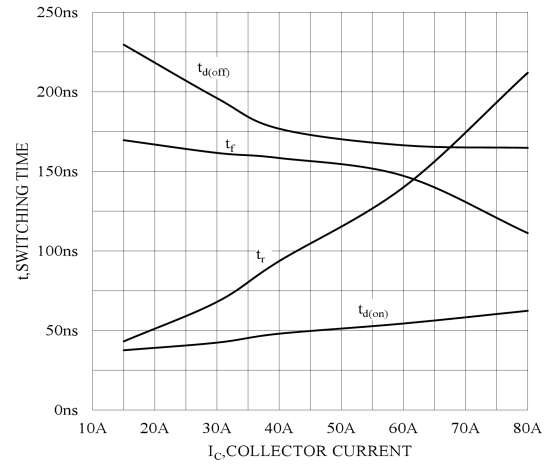


Figure 8. Switching times as I_C
($T_J=150^\circ\text{C}$, $V_{CC}=600\text{V}$, $V_{GE}=-7.5/15\text{V}$, $R_G=10\Omega$)

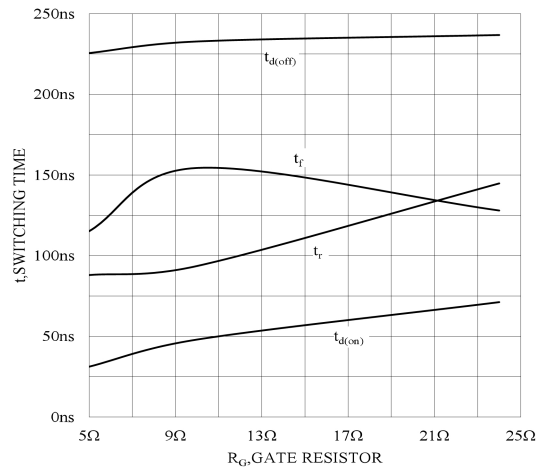


Figure 9. Switching times as R_G
($T_J=150^\circ\text{C}$, $V_{CC}=600\text{V}$, $V_{GE}=-7.5/15\text{V}$, $I_C=40\text{A}$)

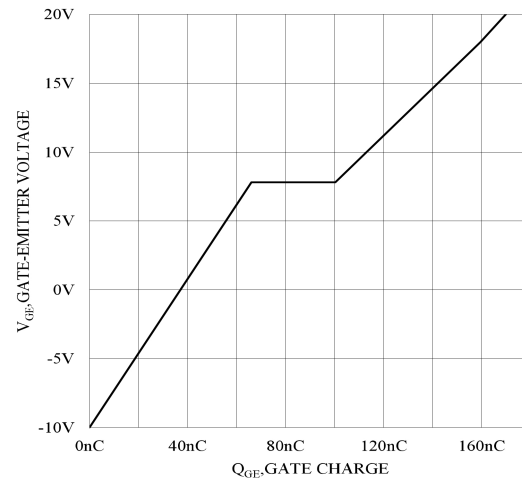


Figure 10. Typical gate charge
($V_{CC}=600\text{V}$, $I_C=40\text{A}$)

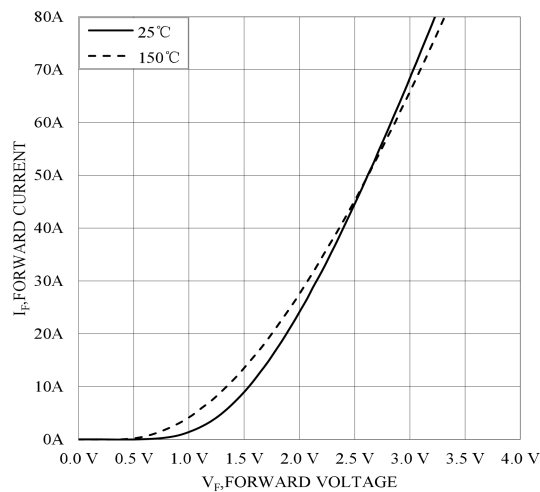


Figure 11. Diode forward current as V_F

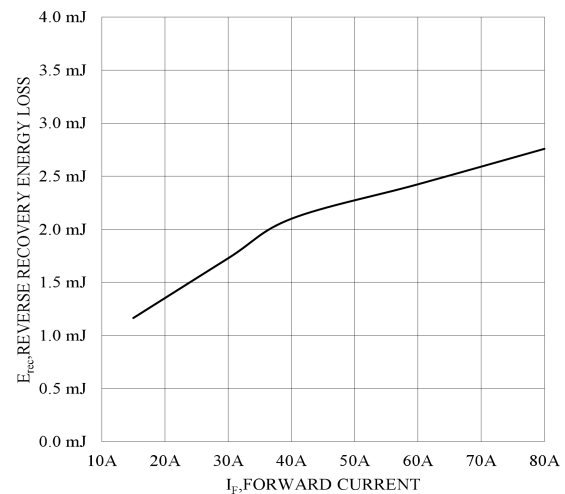


Figure 12. Diode reverse recovery loss as I_F
($T_J=150^\circ\text{C}$, $V_R=600\text{V}$, $R_G=10\Omega$)

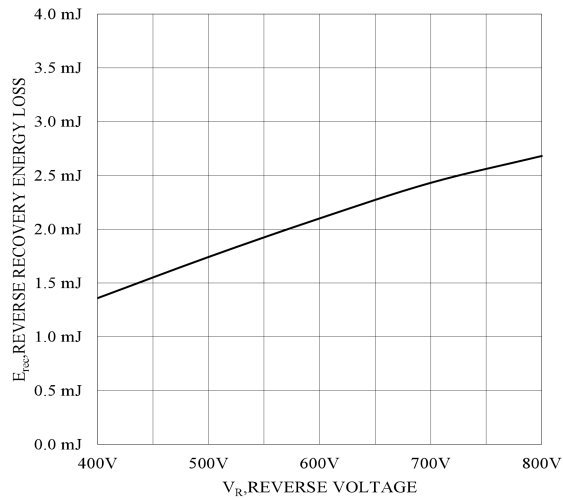


Figure 13. Diode reverse recovery loss as R_G
($T_j=150^\circ\text{C}$, $I_F=40\text{A}$, $R_G=10\Omega$)

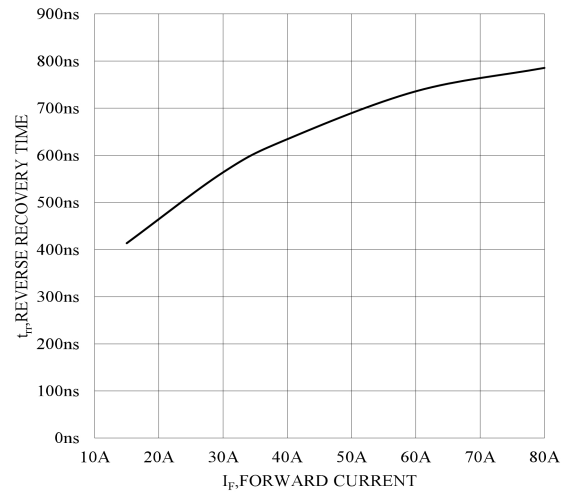


Figure 14. Diode reverse recovery time as I_F
($T_j=150^\circ\text{C}$, $V_R=600\text{V}$, $R_G=10\Omega$)

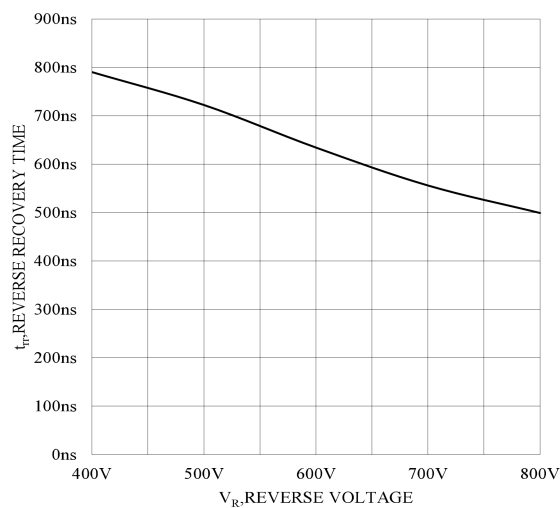
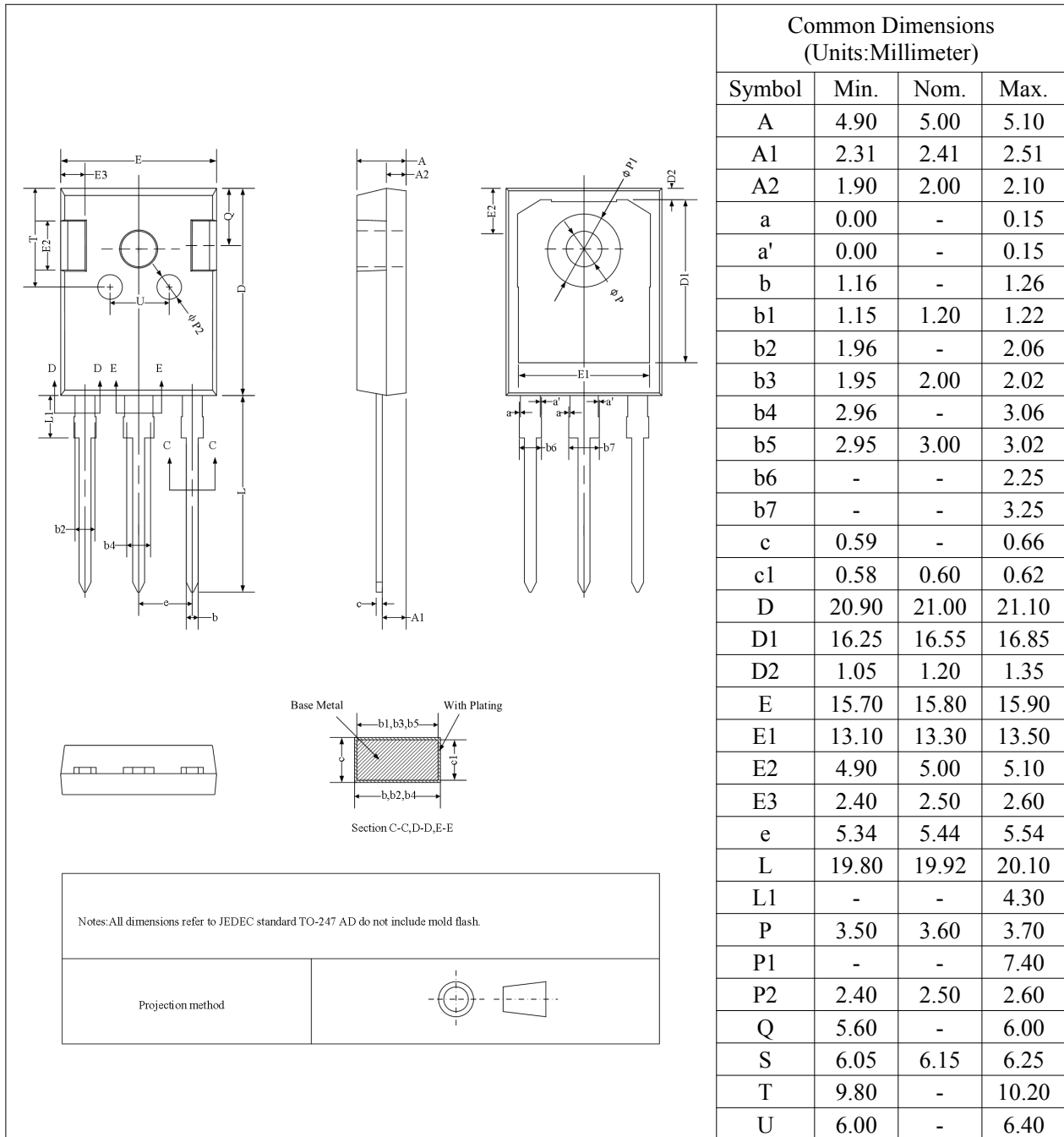


Figure 15. Diode reverse recovery time as V_R
($T_j=150^\circ\text{C}$, $I_F=40\text{A}$, $R_G=10\Omega$)



TO247-3 Outline Dimensions:

TO247-3 外形尺寸



Packing

包装

Packing	pcs/tube	tube/ inner box	inner box/ carton	pcs/carton
Tube	30	12	6	2160



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